Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/805,158	ONO ET AL.
Examiner	Art Unit
Marcos D. Pizarro-Crespo	2814

	SEARCHED					
Class	Subclass	Date	Examiner			
257	288,295 310,314 324-326 410,411					
438	287,288	2/28/2006	MDP			
<u> </u>						

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH S		)
	DATE	EXMR
EAST search for paper no. 0705 made of record.	7/14/2005	MDP
IEEE Xplore search for paper no. 0705 made of record.	7/14/2005	MDP
Updated EAST search for paper no. 11/05 made of record.	11/14/2005	mdp
Updated EAST search for paper no. 3/2006.	2/28/2006	MDP